Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/751,399	YEH ET AL.	
Examiner	Art Unit	
Huan H. Tran	2861	

SEARCHED				
Class	Subclass	Date	Examiner	
347	9,12,13	11/10/2005	ннт	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference search hist	search_see ory printout	4/29/2006	ннт

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST text search (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM TDB)_see search history printout	11/10/2005	ннт	
EAST text search updated	4/29/2006	ннт	
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